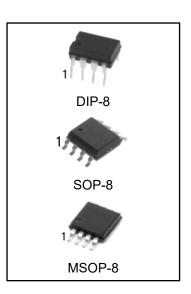


# **CMOS** general purpose timer

### **FEATURES**

- Exact equivalent in most cases for SE/NE555.
- Low Supply Current.
- High speed operation 500 kHz guaranteed.
- Wide operation supply voltage range 2 to 18 volts.
- Timing from microseconds through hours.
- Operates in both astable and monostable modes.
- Adjustable duty cycle.
- High output source/sink driver can drive TTL/CMOS



### ORDERING INFORMATION

DEVICE	Package Type	MARKING	Packing	Packing Qty
LMC555PG	DIP-8	LMC555	TUBE	2000pcs/box
LMC555DRG	SOP-8	LMC555	REEL	2500pcs/reel
LMC555DGKRG	MSOP-8	C555	REEL	3000pcs/reel

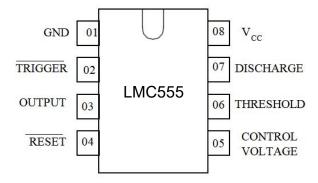


### **GENERAL DESCRIPTION**

The LMC555 is CMOS RC timers providing significantly improved performance over the standard SE/NE555 and 355 timers, while at the same time being direct replacements for those devices in most applications. Improved parameters include low supply current, wide operating supply voltage range, low THRESHOLD, TRIGGER and RESET currents, no crowbarring of the supply current during output transitions, higher frequency performance and no requirement to decouple CONTROL VOLTAGE for stable operation.

Specifically, the LMC555 is stable controller capable of producing accurate time delays of frequencies.

### **PIN ASSIGNMENT**



### TRUTH TABLE

THRESHOLD	TRIGGER	RESET	OUTPUT	DISCHARGE
X	X	L	L	ON
> 2/3 V <sub>CC</sub>	> 1/3 V <sub>CC</sub>	Н	L	ON
< 2/3 V <sub>CC</sub>	> 1/3 V <sub>CC</sub>	Н	STABLE	STABLE
Х	< 1/3 V <sub>CC</sub>	Н	Н	OFF



# **Maximum Ratings And Recommended Operating Conditions**

		Recommende condi		Maximum ratings		
Parameter, unit	Symbol	Val	ue	Val	ue	
		min	max	min	max	
Supply Voltage, V	VCC	2.0	18.0	0	18.0	
Output Current, mA	Io	-	20	-	100	
Input Voltage, V	VTH, VTRIG, VRST	-	-	-0.3	V <sub>CC</sub> +0.3	
Power Dissipation, mW	P <sub>D</sub>	-	-	-	200	
Operating Temperature,°C	TOPR	-40	85	-40	85	
Storage Temperature,°C	TSTG	-	-	-65	150	
Lead Temperature, 1 mm from Case for 10 Seconds,°C	TSOLDER	-	-		245	

**Note:** Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is intended to be functional, but specific performance is not ensured.



	DC ELECTRICAL CHARACTERISTICS (Voltages Referenced to GND)  Test Conditions Value									
Parameter, units	Symbol	IOL, IOH	VCC, B	min	max	Tempe- rature, °C				
Throubold Voltage V	VTH		5.0	0.65 V <sub>CC</sub>	0.70 V <sub>CC</sub>	25±10				
Threshold Voltage, V	۷ΙΠ		5.0	0.60 V <sub>CC</sub>	0.80 V <sub>CC</sub>	-20, 70				
Trigger voltage, V	VTRIG		5.0	0.31 V <sub>CC</sub>	0.36 V <sub>CC</sub>	25±10				
Trigger voltage, v	VIRIG		5.0	0.28 V <sub>CC</sub>	0.40 V <sub>CC</sub>	-20, 70				
			2.0	0.4	1.0	25±10				
Reset voltage, V	VRST		18.0	0.4	1.0	23 ± 10				
reset voltage, v	*1(01		2.0	0.2	1.5	-20, 70				
			18.0	0.2	1.0	-20, 70				
Control Voltage Lead, V	VCV			0.65 V <sub>CC</sub>	0.69 V <sub>CC</sub>	25 10				
Control voltage Lead, v	• 6 v			0.60 V <sub>CC</sub>	0.80 V <sub>CC</sub>	-20, 70				
	VoL	I <sub>OL</sub> = 3.2 mA	5.0		0.4	25±10				
Output voltage Low, V		I <sub>OL</sub> = 20 mA	15.0		1.0	20 10				
Output voltage Low, v		$I_{OL}$ = 3.2 mA	5.0		0.6	-20, 70				
		I <sub>OL</sub> = 20 mA	15.0		1.5	-20, 70				
			5.0	4.0		25±10				
Output voltage High, V	Vон	I <sub>OH</sub> = -0.8 mA	15.0	14.3		23 ± 10				
Output voitage riigii, v	•011	Юн – -0.0 ПІА	5.0	3.5		-20, 70				
			15.0	14.0		-20, 70				
			2.0		200	25±10				
Supply Current, µA	ICC		18.0		300	20 - 10				
Juppiy Julioni, pr	100		2.0		400	-20, 70				
			18.0		600	-20, 10				



## AC ELECTRICAL CHARACTERISTICS

		Test Conditions		Va	Tempe-	
Parameter, unit	Symbol	R <sub>L</sub> , C <sub>L</sub>	VCC, V	Min	Max	rature, °C
Rise (Fall) Time of	tTHL,	$R_L = 10 \text{ M}$ , $C_L = 10 \text{ pF}$	5.0	35	75	25±10
Output,ns	tTLH	- , - ,		70	150	-20, 70
Guaranteed Max	fMAX	Astable Operation	2.0-	500		25±10
Osc Freq,kHz		•	18.0	200		-20, 70
Initial accuracy, %				5		
Drift with Tomporature			5.0		0.02	
Drift with Temperature,	f	R <sub>L</sub> = 1 - 100 k	10.0		0.03	-20, 70
707 C		$C_L = 0.1 \mu F$	15.0		0.06	
Drift with Supply Voltage,	f		5.0		3	25±10
%/B	ſ		5.0		6	-20, 70

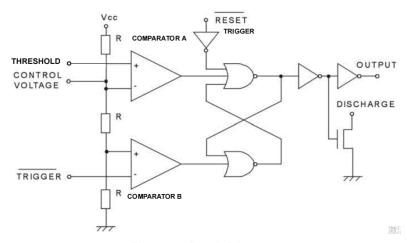


Figura 1. Block Diagram

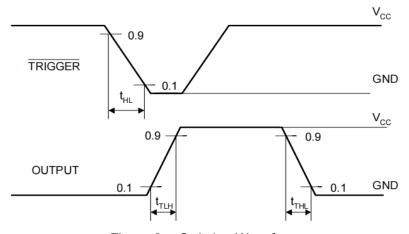
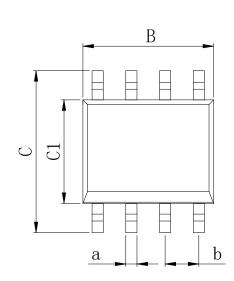


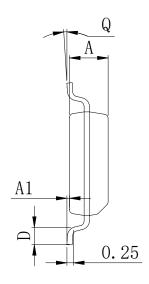
Figura 2. Switcing Waveforms



## **PHYSICAL DIMENSIONS**

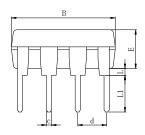
### SOP-8



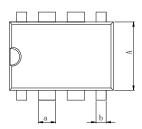


Dimensions In Millimeters(SOP-8)									
Symbol:	Α	A1	В	С	C1	D	Q	а	b
Min:	1.35	0.05	4.90	5.80	3.80	0.40	0°	0.35	1.27 BSC
Max:	1.55	0.20	5.10	6.20	4.00	0.80	8°	0.45	1.27 BSC

### DIP-8





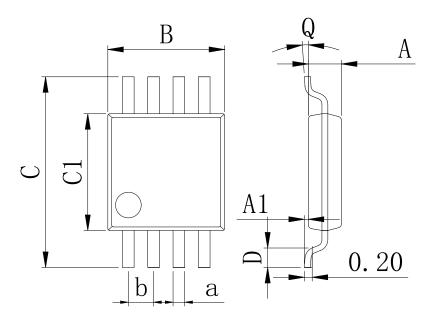


Dimensions In Millimeters(DIP-8)											
Symbol:	Α	В	D	D1	Е	L	L1	а	b	С	р
Min:	6.10	9.00	8.10	7.42	3.10	0.50	3.00	1.50	0.85	0.40	- 2.54 BSC
Max:	6.68	9.50	10.9	7.82	3.55	0.70	3.60	1.55	0.90	0.50	



## **PHYSICAL DIMENSIONS**

MSOP-8



Dimensions In Millimeters(MSOP-8)									
Symbol:	Α	A1	В	С	C1	D	Q	а	b
Min:	0.80	0.05	2.90	4.75	2.90	0.35	0°	0.25	0.65 BSC
Max:	0.90	0.20	3.10	5.05	3.10	0.75	8°	0.35	0.00 BSC



## **REVISION HISTORY**

DATE	REVISION	PAGE
2015-3-17	New	1-9
2023-9-14	Update encapsulation type . Update Lead Temperature . Updated DIP-8 dimension . Add annotation for Maximum Ratings.	1、3、6



#### **IMPORTANT STATEMENT:**

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